

Notice of References Cited

Application/Control No.

10/577,648

Applicant(s)/Patent Under
Reexamination
YAMASHITA ET AL.

Examiner

HANA A. SANEI

Art Unit

2889

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0095945	05-2005	Chang et al.	445/025
*	B	US-6,814,832	11-2004	Utsunomiya, Sumio	156/230
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

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